

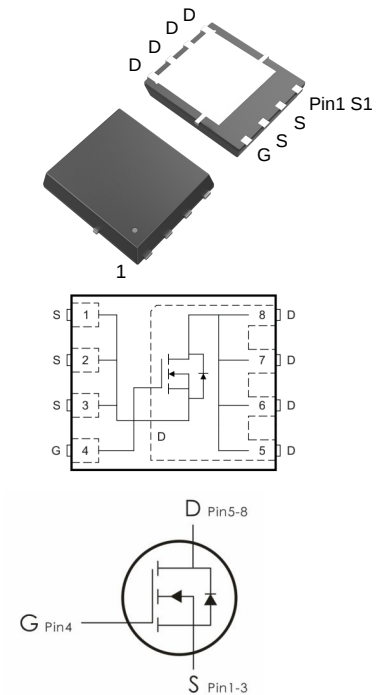
Description:

This N-Channel MOSFET uses advanced SGT technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=100V, I_D=30A, R_{DS(on)} < 25m\Omega @ V_{GS}=10V$ (Typ: $18m\Omega$)
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density SGT technology for ultra low $R_{DS(on)}$.
- 5) Excellent package for good heat dissipation.
- 6) MSL3



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
NH025T2G-L	H025T2-L	DFN5*6-8	5000 pcs/Reel

Absolute Maximum Ratings: ($T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	30	A
	Continuous Drain Current- $T_c=100^\circ\text{C}$ ¹	21	
I_{DM}	Pulsed Drain Current ²	120	
P_D	Power Dissipation	22	W
E_{AS}	Single pulse avalanche energy ³	19	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	5.7	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance Junction to mbient ⁴	65	$^\circ\text{C}/\text{W}$

Electrical Characteristics: ($T_c=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Sourtce Breakdown Voltage	V _{GS} =0V, I _D =250 μ A	100	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} =0V, V _{DS} =100V	---	---	1	μ A
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 20V, V _{DS} =0A	---	---	± 100	nA
On Characteristics						
V _{GS(th)}	Gate-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μ A	1	1.7	2.5	V
R _{DS(ON)}	Drain-Source On Resistance ⁴	V _{GS} =10V, I _D =10A	---	18	25	m Ω
		V _{GS} =4.5V, I _D =5A	---	23.5	30	
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} =50V, V _{GS} =0V, f=1MHz	---	700	---	pF
C _{oss}	Output Capacitance		---	179	--	
C _{rss}	Reverse Transfer Capacitance		---	5.1	---	
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DS} =50V, R _L =2.5 Ω, R _G =6 Ω ,V _{GS} =10V	---	4.3	---	ns
t _r	Rise Time		---	5.1	---	ns
t _{d(off)}	Turn-Off Delay Time		---	17	---	ns
t _f	Fall Time		---	8.7	---	ns
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =6.6A	---	11	---	nC
Q _{gs}	Gate-Source Charge		---	2.1	---	nC
Q _{gd}	Gate-Drain “Miller” Charge		---	3.3	---	nC
Drain-Source Diode Characteristics						
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _{SD} =30A	---	0.7	1.0	V
I _S	Continuous Drain Curren	V _D =V _G =0V	---	---	30	A
I _{SM}	Pulsed Drain Current		---	---	120	A
T _{rr}	Reverse Recovery Time	I _F =6.6A, T _J =25℃	---	40	---	ns
Q _{rr}	Reverse Recovery Charge	dl/dt=100A/us	---	31	---	nC

Notes:

1. Computed continuous current assumes the condition of $T_{j,Max}$ while the actual continuous current depends on the thermal & electro-mechanical application board design
2. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
3. EAS condition : $T_J=25^{\circ}C, V_{DD}=50V, V_G=10V, L=0.1mH$
4. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 0.5\%$

Typical Characteristics: ($T_c=25^{\circ}C$ unless otherwise noted)

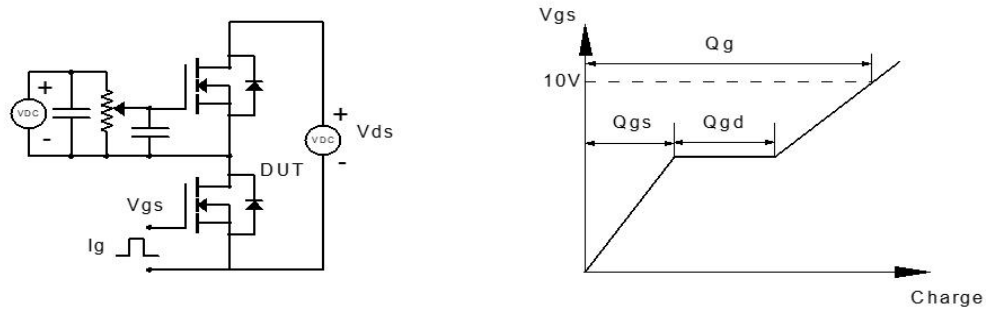


Figure 1: Gate Charge Test Circuit & Waveform

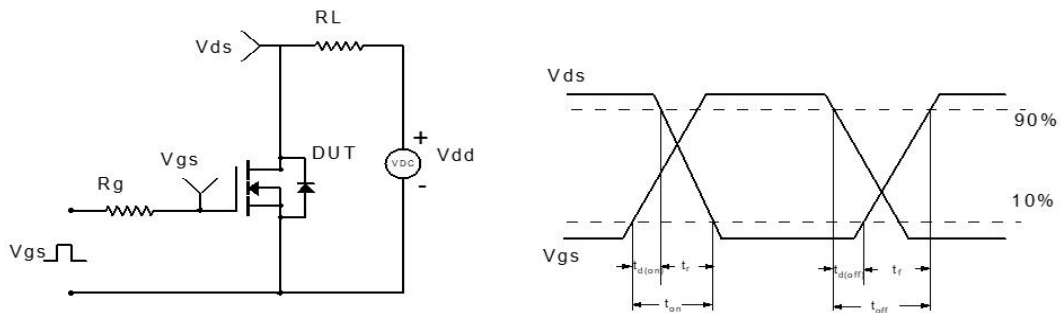


Figure 2: Resistive Switching Test Circuit & Waveform

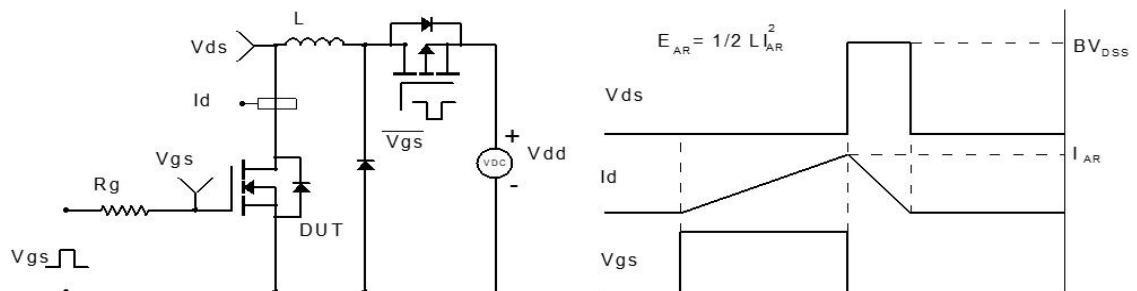


Figure 3: Unclamped Inductive Switching Test Circuit & Waveform

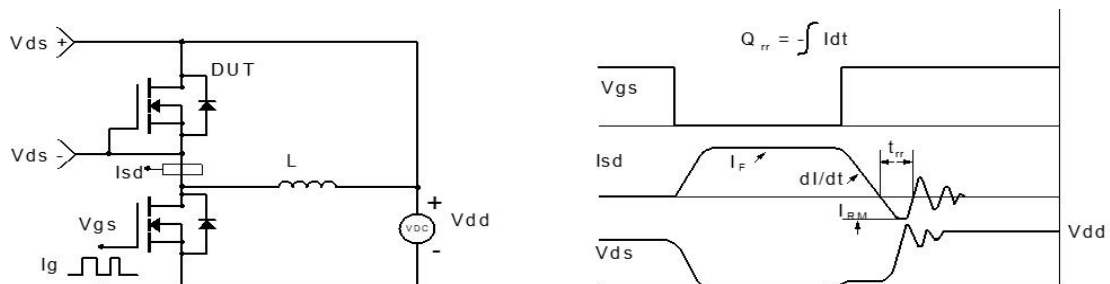
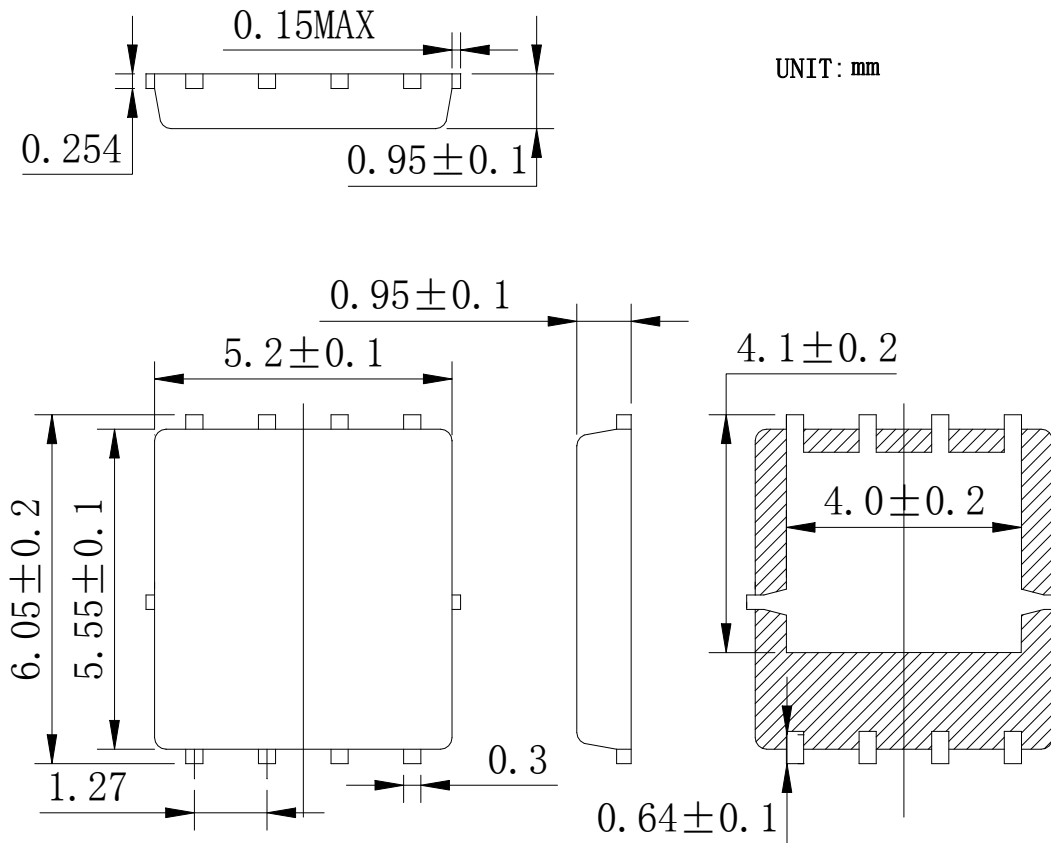


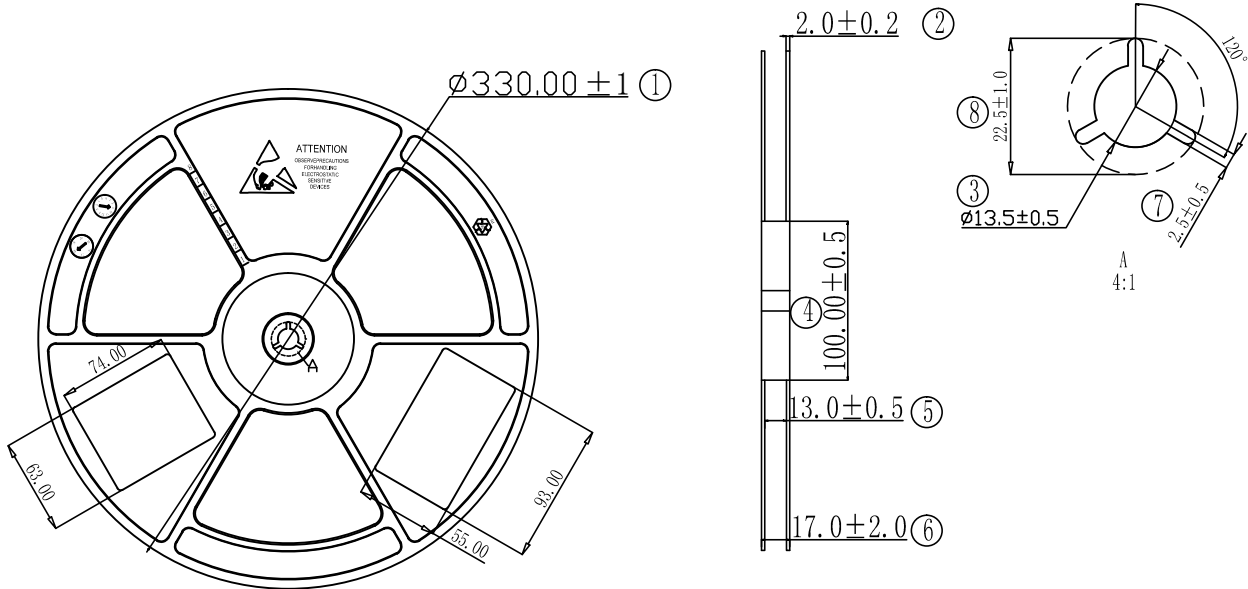
Figure 4: Diode Recovery Test Circuit & Waveform

DFN5×6-8 Package Information:

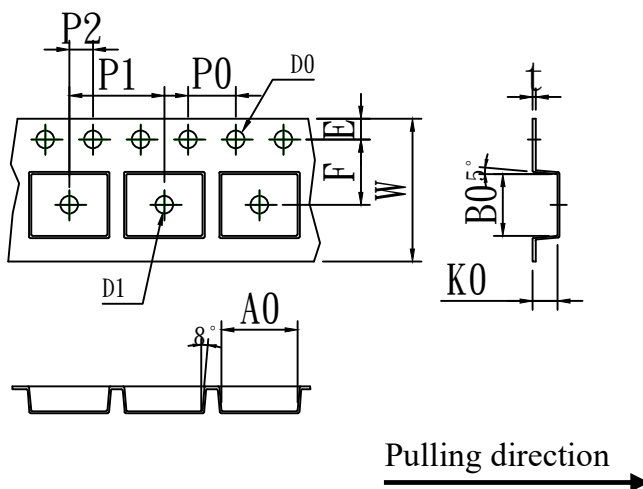


Tape & Reel Information

Dimensions in mm



Symbol	A0	B0	K0	D0	D1	P0	P1	10*P0
Spec	6.15 $\pm$ 0.10	5.40 $\pm$ 0.10	1.30 $\pm$ 0.10	1.55 $\pm$ 0.10	1.55 $\pm$ 0.10	4.00 $\pm$ 0.10	8.00 $\pm$ 0.10	40.00 $\pm$ 0.10
Symbol	W	E	F	P2	t			
Spec	12.00 $\pm$ 0.10	1.75 $\pm$ 0.10	5.50 $\pm$ 0.10	2.00 $\pm$ 0.10	0.20 $\pm$ 0.05			



Marking Information:

①. Doingter LOGO

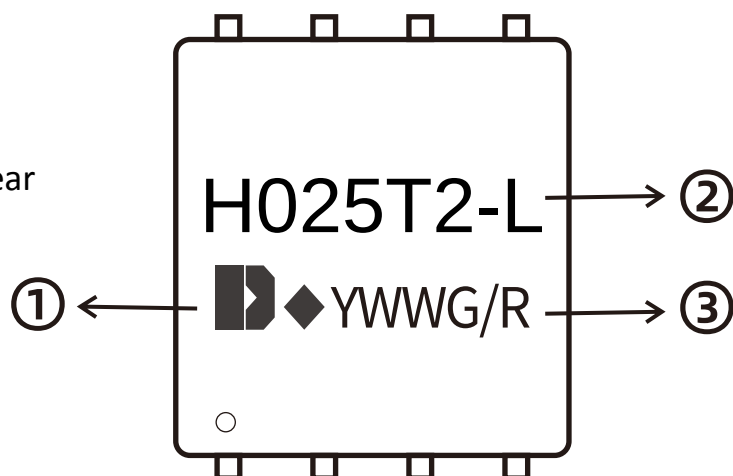
②. Part NO.

③. Date Code(YWWG / R)

Y : Year Code , last digit of the year

WW : Week Code(01-53)

G/R : G(Green) /R(Lead Free)



Previous Version

Version	Date	Subjects (major changes since last revision)
1.0	2025-07-06	Release of final version

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